Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/603,419	HUYNH, DUANE Q.
Examiner	Art Unit
Tianjie Chen	2627

	SEARCHED			
Class	Subclass	Date	Examiner	
360	264.2	1/24/2008	TJ	
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
360	264.2	1/24/2008	TJ
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